

FDD6296/FDU6296

30V N-Channel Fast Switching PowerTrench[®] MOSFET

General Description

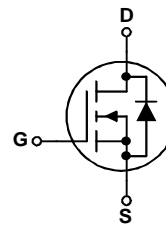
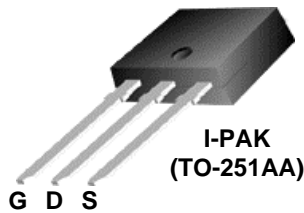
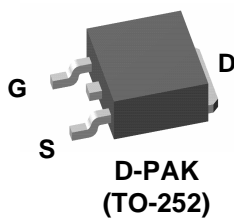
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$ and fast switching speed.

Applications

- DC/DC converter
- Power management

Features

- 50A, 30 V $R_{DS(ON)} = 8.8\text{ m}\Omega @ V_{GS} = 10\text{ V}$
 $R_{DS(ON)} = 11.3\text{ m}\Omega @ V_{GS} = 4.5\text{ V}$
- Low gate charge
- Fast switching
- High performance trench technology for extremely low $R_{DS(ON)}$



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|----------------|--|-------------|------------------|
| V_{DSS} | Drain-Source Voltage | 30 | V |
| V_{GSS} | Gate-Source Voltage | ± 20 | |
| I_D | Continuous Drain Current @ $T_C=25^\circ\text{C}$ (Note 3) | 50 | A |
| | @ $T_A=25^\circ\text{C}$ (Note 1a) | 15 | |
| | Pulsed (Note 1a) | 100 | |
| P_D | Power Dissipation @ $T_C=25^\circ\text{C}$ (Note 3) | 52 | W |
| | @ $T_A=25^\circ\text{C}$ (Note 1a) | 3.8 | |
| | @ $T_A=25^\circ\text{C}$ (Note 1b) | 1.6 | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to +175 | $^\circ\text{C}$ |

Thermal Characteristics

| | | | |
|-----------------|---|-----|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case (Note 1) | 2.9 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1a) | 40 | |
| | Thermal Resistance, Junction-to-Ambient (Note 1b) | 96 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape width | Quantity |
|----------------|---------|----------------|-----------|------------|------------|
| FDD6296 | FDD6296 | D-PAK (TO-252) | 13" | 12mm | 2500 units |
| FDU6296 | FDU6296 | I-PAK (TO-251) | Tube | N/A | 75 |

Electrical Characteristics

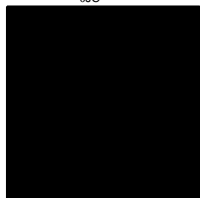
$T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|-----|-------------------|---------------------|----------------------|
| Drain-Source Avalanche Ratings (Note 2) | | | | | | |
| E_{AS} | Drain-Source Avalanche Energy | Single Pulse, $V_{DD} = 15\text{ V}$, $I_D = 15\text{ A}$ | | | 165 | mJ |
| I_{AS} | Drain-Source Avalanche Current | | | | 15 | A |
| Off Characteristics | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0\text{ V}$, $I_D = 250\ \mu\text{A}$ | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$, Referenced to 25°C | | 29 | | mV/ $^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24\text{ V}$, $V_{GS} = 0\text{ V}$ | | | 1 | μA |
| I_{GSS} | Gate-Body Leakage | $V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$ | | | ± 100 | nA |
| On Characteristics (Note 2) | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$ | 1 | 1.7 | 3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$, Referenced to 25°C | | -0.5 | | mV/ $^\circ\text{C}$ |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}$, $I_D = 15\text{ A}$ $V_{GS} = 4.5\text{ V}$, $I_D = 13\text{ A}$ $V_{GS} = 10\text{ V}$, $I_D = 15\text{ A}$, $T_J = 125^\circ\text{C}$ | | 7.5 9.0 9.3 | 8.8 11.3 15.0 | m Ω |
| g_{FS} | Forward Transconductance | $V_{DS} = 5\text{ V}$, $I_D = 15\text{ A}$ | | 58 | | S |
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS} = 15\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1.0\text{ MHz}$ | | 1440 | | pF |
| C_{oss} | Output Capacitance | | | 400 | | pF |
| C_{riss} | Reverse Transfer Capacitance | | | 140 | | pF |
| R_G | Gate Resistance | $V_{GS} = 15\text{ mV}$, $f = 1.0\text{ MHz}$ | | 1.3 | | Ω |
| Switching Characteristics (Note 2) | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 15\text{ V}$, $I_D = 1\text{ A}$, $V_{GS} = 10\text{ V}$, $R_{GEN} = 6\ \Omega$ | | 11 | 19 | ns |
| t_r | Turn-On Rise Time | | | 6 | 11 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 29 | 46 | ns |
| t_f | Turn-Off Fall Time | | | 13 | 23 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 15\text{ V}$, $I_D = 15\text{ A}$, $V_{GS} = 10\text{ V}$ | | 22.5 | 31.5 | nC |
| Q_g | Total Gate Charge | $V_{DS} = 15\text{ V}$, $I_D = 15\text{ A}$, $V_{GS} = 5\text{ V}$ | | 12.2 | 17 | nC |
| Q_{gs} | Gate-Source Charge | | | 4 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 3.5 | | nC |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I_S | Maximum Continuous Drain-Source Diode Forward Current | | | | 3.2 | A |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0\text{ V}$, $I_S = 3.2\text{ A}$ (Note 2) | | 0.74 | 1.2 | V |
| t_{rr} | Diode Reverse Recovery Time | $I_F = 15\text{ A}$, $dI_F/dt = 100\text{ A}/\mu\text{s}$ | | 25 | | nS |
| Q_{rr} | Diode Reverse Recovery Charge | | | 13 | | nC |

Electrical Characteristics (cont'd)

Notes:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) $R_{\theta JA} = 40^{\circ}\text{C/W}$ when mounted on a 1in^2 pad of 2 oz copper



b) $R_{\theta JA} = 96^{\circ}\text{C/W}$ when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μs , Duty Cycle < 2.0%

3. Maximum current is calculated as:
current limitation is 21A

$$\sqrt{\frac{P_D}{R_{DS(on)}}}$$

where P_D is maximum power dissipation at $T_C = 25^{\circ}\text{C}$ and $R_{DS(on)}$ is at $T_{J(max)}$ and $V_{GS} = 10\text{V}$. Package

Typical Characteristics

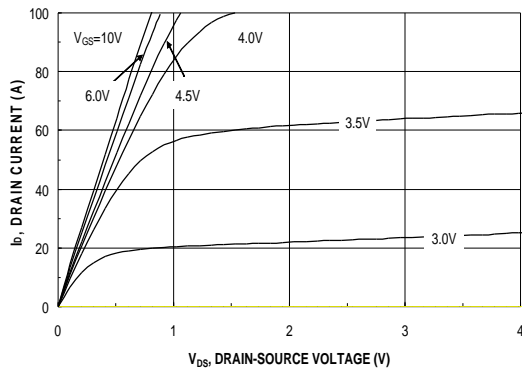


Figure 1. On-Region Characteristics

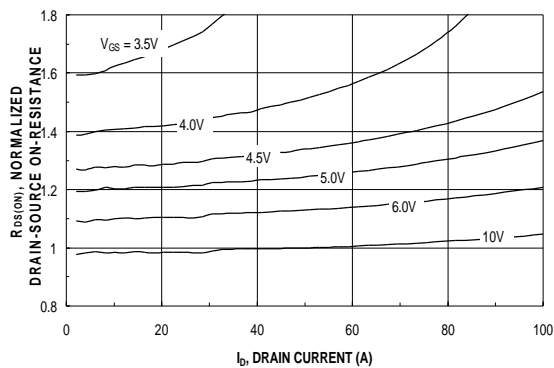


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

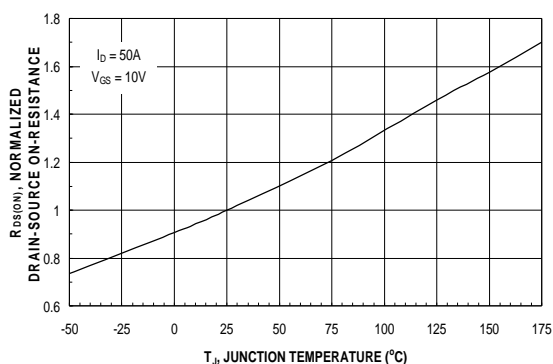


Figure 3. On-Resistance Variation with Temperature

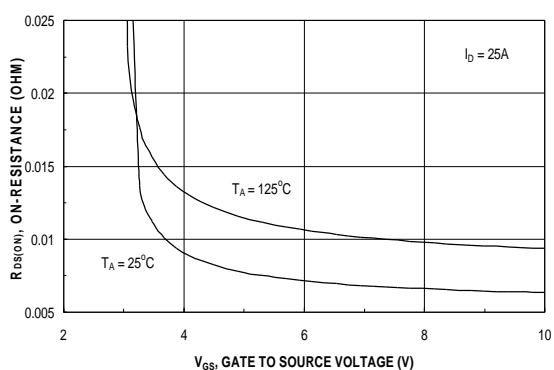


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

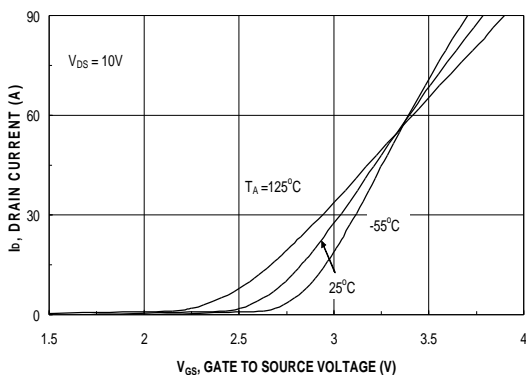


Figure 5. Transfer Characteristics

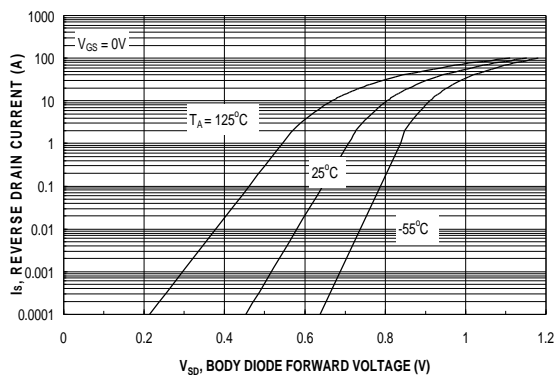


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature